

1. Description

KNX2912A, uses advanced trench technology to provide excellent $R_{DS(ON)}$, Low gate charge, It can be used in a wide variety of applications.

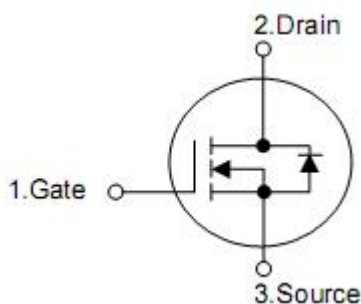
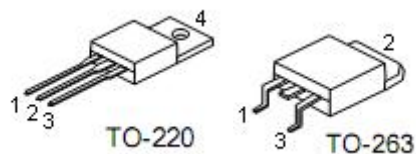
2. Features

- $V_{DS}=120V, I_D=130A$ $R_{DS(ON)}$ (typ.)= $6.0m\Omega$ @ $V_{GS}=10V$
- High density cell design for lower R_{dson}
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high EAS
- Excellent package for good heat dissipation

3. Applications

- Power switching application
- Hard switched and High frequency circuits
- Uninterruptible power supply

4. Symbol



Pin	Function
1	Gate
2	Drain
3	Source
4	Drain

5. Ordering Information

Part Number	Package	Brand
KNB2912A	TO-263	KIA
KNP2912A	TO-220	KIA

6. Absolute maximum ratings

Parameter	Symbol	Rating	Units
Drain-source voltage	V_{DS}	120	V
Gate-source voltage	V_{GS}	+20	V
Continuous drain current	I_D	130	A
Pulsed drain current ^(Note1)	I_{DM}	520	A
Single pulse avalanche energy ^(Note2)	E_{AS}	1155	mJ
Derating Factor above 25°C	P_D	339	W/°C
Operation junction and temperature range	T_J, T_{STG}	-55 to 175	°C

7. Thermal characteristics

Symbol	Parameter	Max	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.44	°C/W

8. Electrical characteristics

 (T_A=25°C, unless otherwise noted)

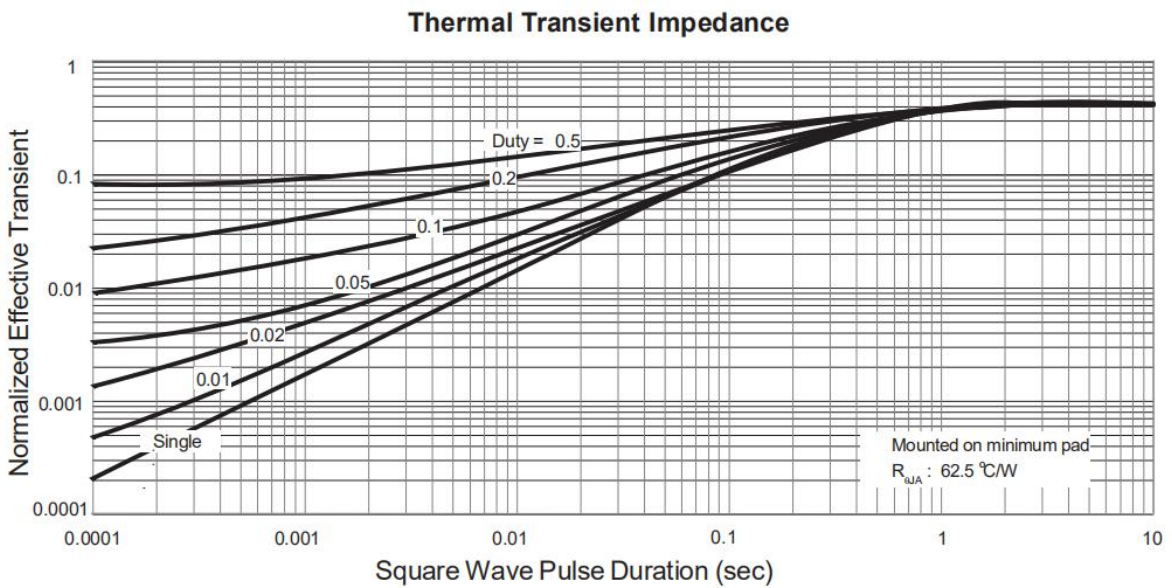
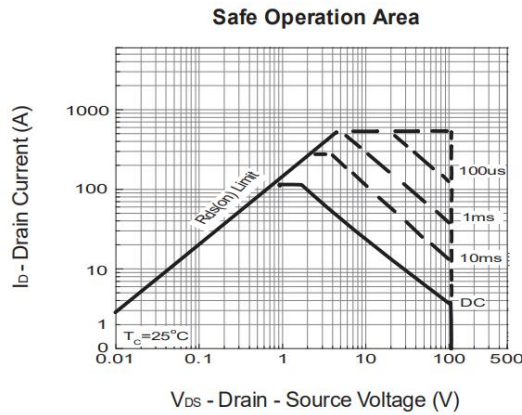
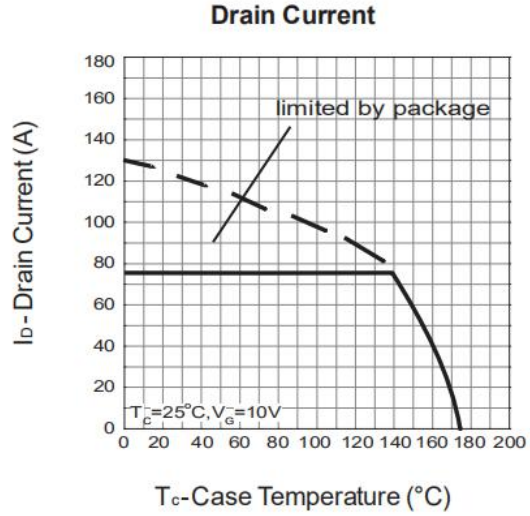
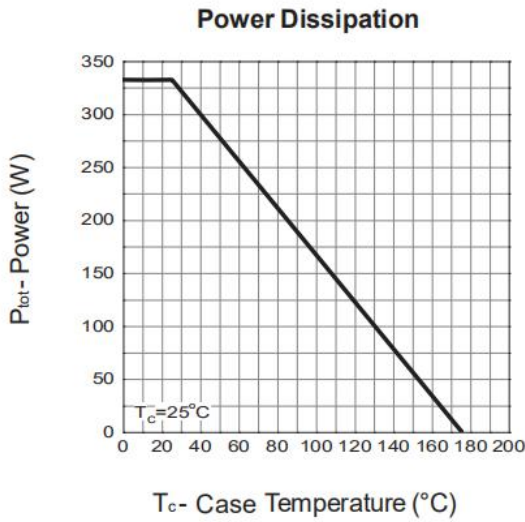
Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
Drain-source breakdown voltage	BV _{DSS}	V _{GS} =0V, I _D =250μA	120	-	-	V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =1200V, V _{GS} =0V	-	-	1	μA
Gate-Source Forward Leakage	I _{GSS(F)}	V _{GS} =+20V	-	-	100	nA
Gate-Source Reverse Leakage	I _{GSS(R)}	V _{GS} =-20V	-	-	-100	nA
On Characteristics						
Drain-source on-Resistance ^(Note3)	R _{DS(on)}	V _{GS} =10V, I _D =30A	-	6.0	7.5	mΩ
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	2.0	3.0	4.0	V
Gate Resistance	R _g	V _{GS} =0V, V _{DS} =0V, F=1MHz	-	3.0	-	Ω
Dynamic Characteristics						
Total gate charge	Q _g	V _{DD} =100V, V _{GS} =10V I _D =85A	-	189	-	nC
Gate-source charge	Q _{gs}		-	29	-	
Gate-drain charge	Q _{gd}		-	90	-	
Turn-on delay time	t _{d(on)}	V _{DD} =60V, I _D =85A, R _{GEN} =6Ω, V _{GS} =10V,	-	35	-	ns
Rise time	t _r		-	46	-	
Turn-off delay time	t _{d(off)}		-	95	-	
Fall time	t _f		-	52	-	
Switching Characteristics ^(Note 4)						
Input capacitance	C _{iss}	V _{DS} =25V, V _{GS} =0V, f=1MHz	-	8120	-	pF
Output capacitance	C _{oss}		-	788	-	
Reverse transfer capacitance	C _{rss}		-	530	-	
Drain-Source Diode Characteristics						
Diode Forward voltage	V _{SD}	V _{GS} =0V, I _S =30A	-	-	1.2	V

Note

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. EAS condition : T_j=25°C, V_{DD}=50V, V_G=10V, L=0.5mH, R_g=1Ω
3. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
4. Guaranteed by design, not subject to production.

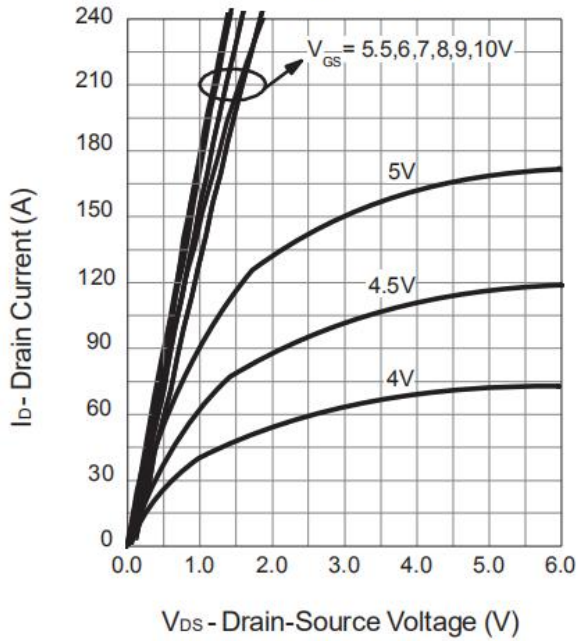
9. Test circuits

Typical Operating Characteristics

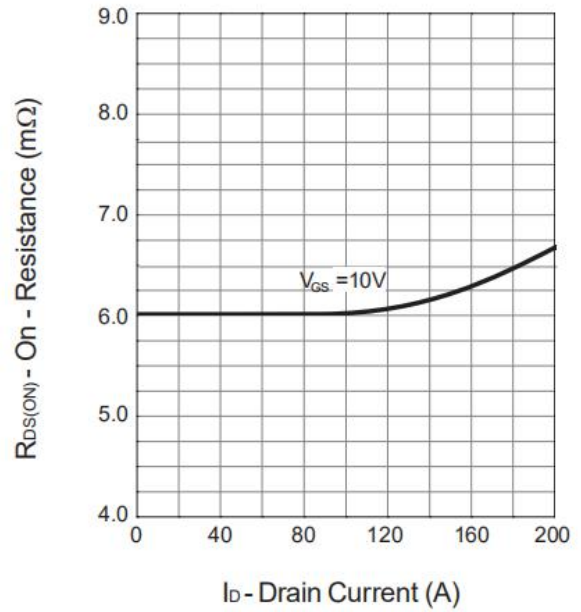


Typical Operating Characteristics (Cont.)

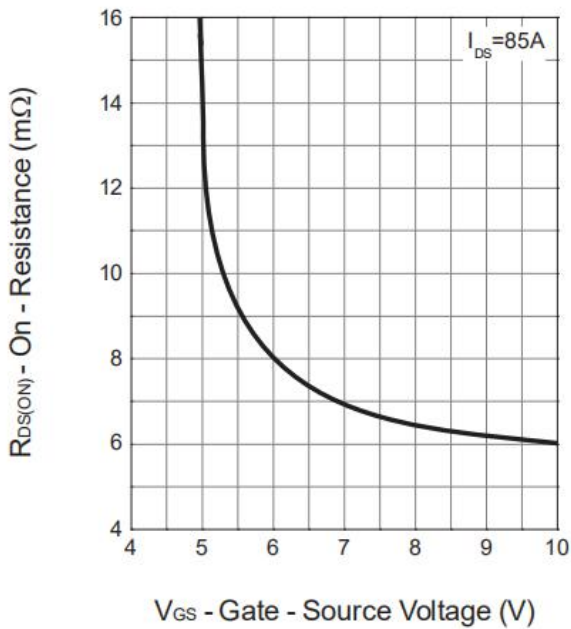
Output Characteristics



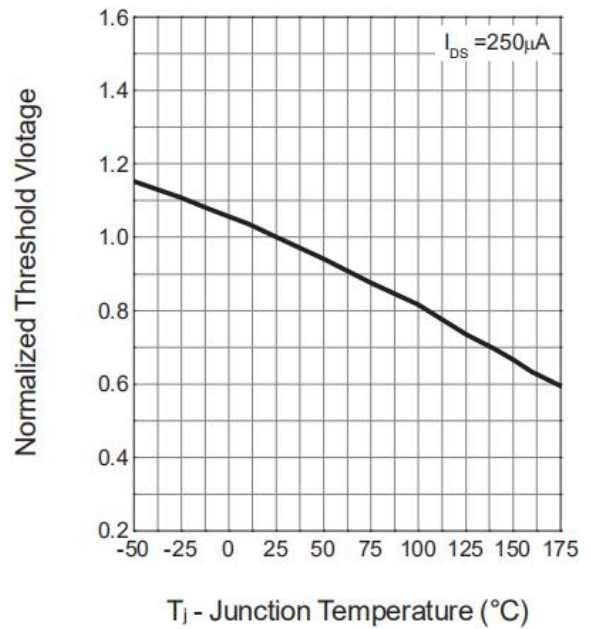
Drain-Source On Resistance



Drain-Source On Resistance

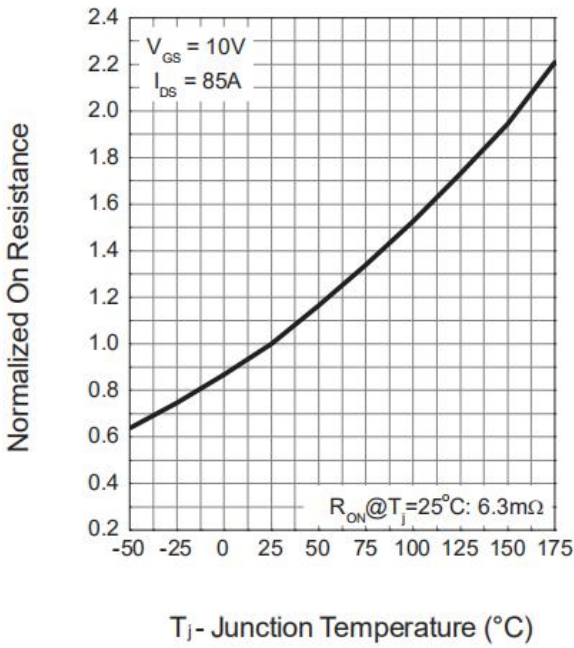


Gate Threshold Voltage

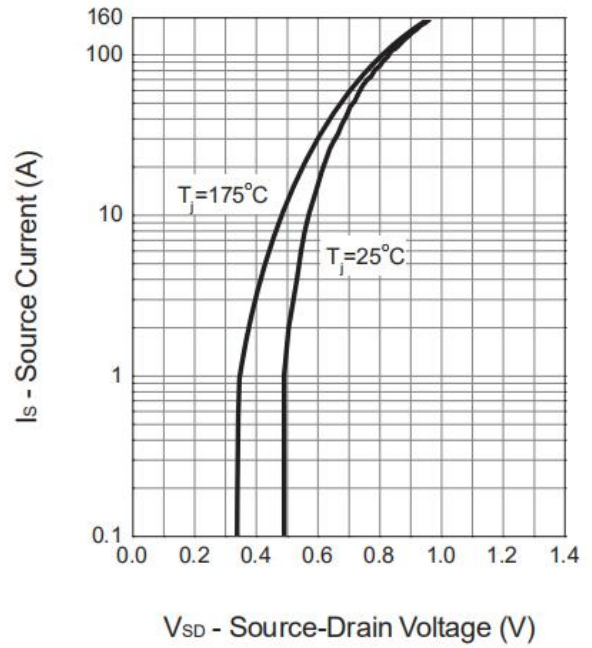


Typical Operating Characteristics (Cont.)

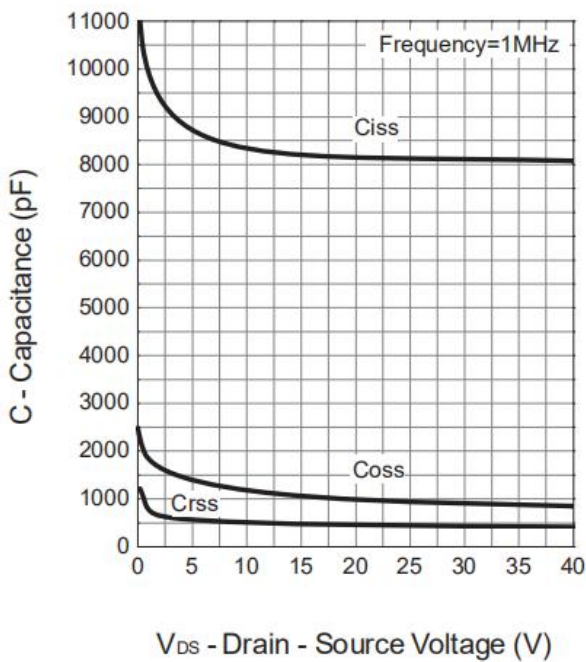
Drain-Source On Resistance



Source-Drain Diode Forward



Capacitance



Gate Charge

